

Magnetic Structure and Ordering of Multiferroic Hexagonal LuFeO₃

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We report on the magnetic structure and ordering of hexagonal LuFeO₃ films of variable thickness grown by molecular-beam epitaxy on YSZ (111) and Al₂O₃ (0001) substrates. These crystalline films exhibit long-range structural uniformity dominated by the polar $P6_3cm$ phase, which is responsible for the paraelectric to ferroelectric transition that occurs above 1000 K. Using bulk magnetometry and neutron diffraction, we find that the system orders into a ferromagnetically canted antiferromagnetic state via a single transition below 155 K regardless of film thickness, which is substantially lower than that previously reported in hexagonal LuFeO₃ films. The symmetry of the magnetic structure in the ferroelectric state implies that this material is a strong candidate for linear magnetoelectric coupling and control of the ferromagnetic moment directly by an electric field.

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Multiferroic materials display both ferroelectric and magnetic order and have been the subject of intense investigation both from fundamental and applied perspectives [1,2]. If both order parameters are coupled, these materials would enable new devices ranging from magnetic field sensors to magnetic random access memory. Unfortunately, single-phase multiferroics are extraordinarily rare; thus far only four room-temperature single-phase multiferroics have been reported: BiFeO₃ [3], BiCoO₃ [4], corundum ScFeO₃ [5], and most recently hexagonal LuFeO₃ (h -LuFeO₃) [6]. The latter compound, h -LuFeO₃ was found to be isostructural with YMnO₃ [Fig. 1(a)] [7,8] when synthesized in thin film form, and antiferromagnetism appears to persist in the ferroelectric state well above room temperature. Our current investigation of the same system reveals that hexagonal LuFeO₃ is a multiferroic, but the onset of magnetic order is well below room temperature.

Specifically, YMnO₃ and other hexagonal manganites, REMnO₃ (RE = Lu, Y, Ho), have been known for some time to exhibit multiferroic properties. Here, ferroelectricity is the result of a structural transition from the nonpolar $P6_3/mmc$ to the polar $P6_3cm$ space group above room temperature ($T_C \sim 900$ K in YMnO₃) [9]. Magnetic order sets in at much lower temperatures ($T_N \sim 80$ K in YMnO₃) [10], which renders these materials unsuitable for multiferroic devices. Even in the magnetically ordered state the coupling between the ferroelectric and magnetic order

parameters is weak [11]. Replacing Mn with Fe in this system has been proposed as one way to increase the magnetic transition temperature as well as the coupling between the two order parameters [12], and has been the recent subject of increased interest [6,13]. Theoretical calculations using first-principles suggest that a weak ferromagnetic moment along the c axis may be deterministically switchable by 180° with an electric field [12].

Reports of antiferromagnetic order above room temperature in h -LuFeO₃ [6] coupled with theoretical predictions of a weak canted moment along the c axis [12] observed at temperatures below 147 K [13], have generated significant interest in this material for applications. In this Letter, we determine through magnetometry and neutron diffraction measurements the intrinsic magnetic structure of h -LuFeO₃ epitaxial films exhibiting uniform $P6_3cm$ structural order. We find that antiferromagnetic order is evident as previously reported [6] but occurs only below 155 K for h -LuFeO₃ films of variable thickness on several substrates (i.e., Al₂O₃ and cubic zirconia). Furthermore, its onset occurs simultaneously with the onset of the weak ferromagnetic canting of the moments. From Raman scattering we demonstrate that h -LuFeO₃ is ferroelectric at room temperature, with a paraelectric-to-ferroelectric transition temperature $T_C = 1020 \text{ K} \pm 50 \text{ K}$. Solving the magnetic structure we confirm that the films magnetically order in the ferroelectric state in a manner consistent with

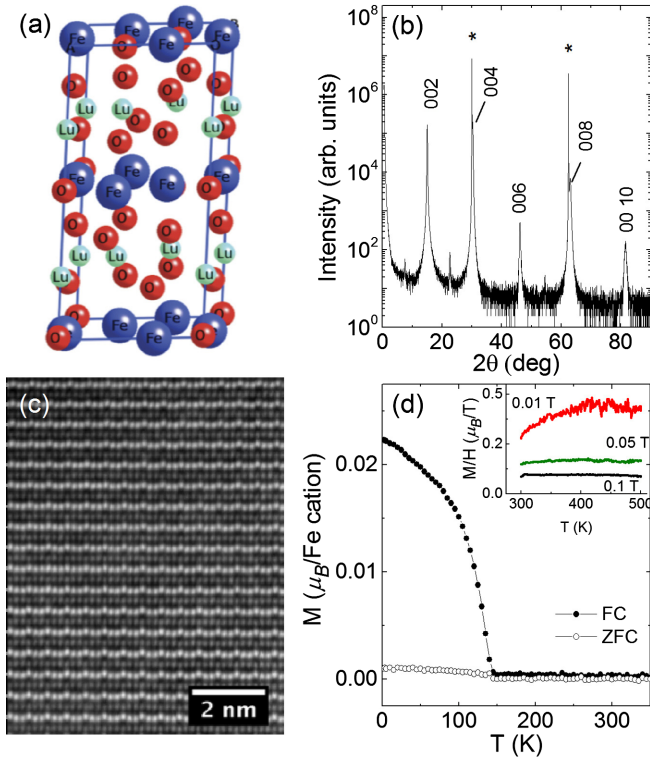


FIG. 1 (color online). Characterization of a 250 nm thick film of h -LuFeO₃ on YSZ (YSZ-250 nm). (a) Schematic of the crystal structure of h -LuFeO₃ with the $P6_3cm$ space group. (b) XRD at room temperature, with h -LuFeO₃ 00 l reflections labeled accordingly; substrate peaks are denoted by (*). (c) STEM image along the [110] direction highlighting the positions of the Lu-ions in the “up down down” pattern demonstrating the $P6_3cm$ structure. (d) Magnetization at 0.01 T under FC (closed circles) and ZFC (open circles) conditions. Inset: high temperature magnetization for magnetic fields 0.01, 0.05, and 0.1 T applied parallel to the c axis.

magnetoelectric theoretical predictions such that electric field-induced reversal of the ferromagnetic moment direction should be achievable below the magnetic ordering temperature ($T < 155$ K). Our results thus contrast with previous reports of room-temperature antiferromagnetic ordering in comparable h -LuFeO₃ films [6]. Subtle, but significant, deviations of the structure from the $P6_3cm$ phase in the films of the previous study are key to interpreting these differences in magnetic ordering temperatures.

We used oxide molecular-beam epitaxy (MBE) to grow six high-quality, single-crystalline films of h -LuFeO₃ with thicknesses from 20 to 250 nm on 10 mm \times 10 mm substrates of either (111)-oriented yttria-stabilized cubic zirconia (YSZ) or (0001) Al₂O₃ [13]. The list of samples is provided in Table 1. For simplicity, each sample considered will be designated by their substrate and LuFeO₃ thickness (e.g., YSZ-200 nm).

In Fig. 1(b), we show as an example a θ - 2θ XRD scan for YSZ-250 nm. The intense narrow peaks come from the substrate, while the other reflections from the film

TABLE I. Lattice parameters and Néel temperatures for each sample determined from neutron diffraction. Errors in parenthesis represent one standard deviation of the last digit as obtained from least-squares fitting.

Sample	a (Å)	c (Å)	T_N
200 nm on YSZ	5.989(5)	11.70(3)	155(5) K
250 nm on YSZ	5.979(5)	11.81(3)	150(1) K
200 nm on Al ₂ O ₃	5.985(5)	11.77(2)	140(2) K
250 nm on Al ₂ O ₃	5.994(5)	11.78(2)	139(1) K
70 nm on Al ₂ O ₃	6.050(30)	11.97(5)	115(20) K
20 nm on Al ₂ O ₃	6.015(10)	11.84(5)	130(15) K

demonstrate that it is single phase. Only 00 l reflections with even l are observed indicating the (001) orientation of the film and consistent with the $P6_3cm$ space group shown in Fig. 1(a). Similar patterns are observed for the remaining samples [14]. From STEM images along the [110] zone axis of h -LuFeO₃ in Fig. 1(c) we find this film is also nearly free of extra Fe-O layers (syntactic intergrowths of LuFe₂O₄) [13], which are occasionally observed in similar films [14]. These images reveal that the Lu atoms in each plane are displaced in an “up down down” pattern over extended length scales consistent with the noncentrosymmetric, polar $P6_3cm$ structural phase. TEM images (Fig. S2, Ref. [6]) from previous investigations of related h -LuFeO₃ films show local regions with the Lu atoms in the “up down down” pattern. These areas are interspersed within larger regions that exhibit a “up middle down” pattern consistent with closely related structural phases such as antipolar $P\bar{3}c$ [15], suggesting that these nonpolar regions are intermixed with the polar $P6_3cm$ phase [15].

The lattice parameters for each sample in the current study were obtained from neutron diffraction measurements of the 300 and 004 nuclear reflections at 5 K (Table 1). These values appear to be independent of both sample thickness and substrate and are within error of previously reported values for stoichiometric films [6,13]. Films with thicknesses ≥ 200 nm or greater exhibit resolution-limited peak shapes at nuclear reflections [14] indicating no distribution of lattice parameters from strain or finite-size effects, while films of 20 and 70 nm are broadened only along 00 l in accordance with reduced physical dimensions along that direction. It thus does not appear that the strain, potentially induced by the substrate-film interface, plays any significant role in determining the crystallographic, ferroelectric, or magnetic properties of this system regardless of film thickness.

Raman measurements, shown for YSZ-200 nm in Fig. 2, reveal that the ferroelectric transition occurs well above room temperature. The observed peak positions in the Raman spectra and relative intensities are very similar to that of hexagonal LuMnO₃ [16], as opposed to those reported for orthorhombic LuFeO₃ [17]. We are able to distinguish at least 10 phonon modes out of the 23 that are

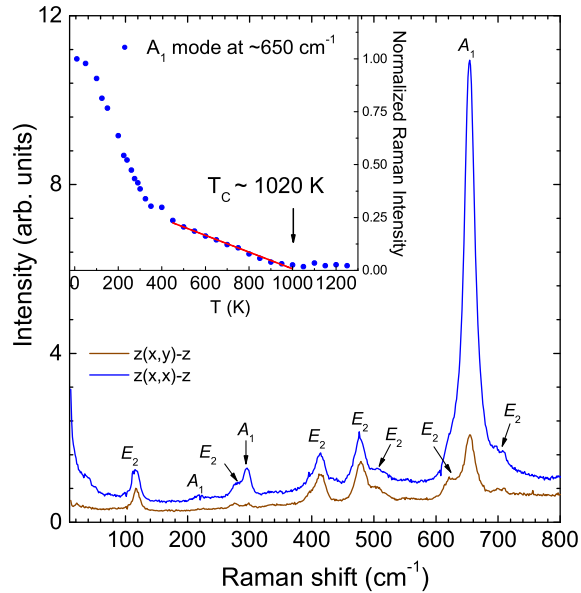


FIG. 2 (color online). Raman spectra of 200 nm thick h -LuFeO₃ (YSZ-200 nm) measured at 10 K using both polarizations [14] demonstrating the Raman active phonon modes in the ferroelectric state of h -LuFeO₃. Inset: Normalized Raman intensity of the A₁ mode (peak around 650 cm⁻¹) as a function of temperature, solid line is a linear fit over the temperature region 400 K < T < 1050 K.

active in the scattering geometries used, consistent with its ferroelectric structure of h -LuFeO₃ [14]. The temperature dependence of the integrated Raman intensity of the strongest A₁ peak, near 655 cm⁻¹ [normalized by the Bose factor $n + 1 = 1/(1 - e^{-\hbar\omega/kT})$] is shown in the inset. The intensity decreases linearly with increasing temperature between 400 and 1000 K, above which no change is observed; a linear fit of the intensity over this temperature region demonstrates a clear transition to a nonpolar phase at $T_c = 1020 \text{ K} \pm 50 \text{ K}$. Piezoelectric force microscopy measurements confirmed ferroelectricity at room temperature in these films through switching of the ferroelectric polarization [14].

As expected from theory [12], bulk magnetization measurements indicate that the onset of ferromagnetic order is not coincident with the ferroelectric transition, instead occurring well below room temperature. Magnetization measurements along the c axis of YSZ-250 nm are shown in Fig. 1(d). A clear transition is evident in the field-cooled data at 143 K. While the magnetization magnitude is small ($\sim 0.02\mu_B$), it is clear evidence for weak ferromagnetism occurring in the ordered phase. The presence of weak ferromagnetism is common among all samples in this study, with onset temperatures between 118 and 150 K [14]. The offset between FC and ZFC at higher temperatures in some samples is indicative of trace amounts of Fe₃O₄ or a similar impurity phase that occurs in conjunction with syntactic intergrowths seen in TEM [14]. Beyond this, we find no evidence for additional magnetic transitions

at or above room temperature in measurements of the magnetic susceptibility, as shown in the inset of Fig. 1(d). Similar susceptibilities have been measured for magnetic fields applied parallel to the plane of the film indicating isotropic magnetic susceptibility above room temperature, in contrast to the previous report [6].

We now turn our focus to the neutron diffraction results, which provide a full picture of the corresponding antiferromagnetic order. We measured the temperature dependence (Fig. 3) of several reflections including the 101, 100, and 102, which are predominantly (or entirely) of magnetic origin. Interpretation of the differences among the temperature dependence of these reflections, however, first requires an understanding of the possible magnetic structures consistent with the $P6_3cm$ space group. Representational analysis reveals that the magnetic and crystallographic unit cells of these materials are identical ($\mathbf{q} = 0$) and that the magnetic structure may fall into six representations: four one-dimensional and two two-dimensional [18–20]. For the hexagonal manganites, the materials measured thus far have been well described by the one-dimensional representations which contain the classic 120° arrangement of spins in a given plane, labeled as Γ_1 to Γ_4 as shown in Figs. 4(a)–4(d), respectively. Planes can either be coupled ferromagnetically (Γ_3 and Γ_4) or antiferromagnetically (Γ_1 and Γ_2) along the c axis, and the moments may lie along the a or b crystallographic axes with respect to the 120° arrangement of the spins. Furthermore, only the Γ_2 representation allows for a net moment along the c axis. Unfortunately, the Fe atoms lie at the $(\frac{1}{3}00)$ position, such that the Γ_1 and Γ_3 representations form a homometric pair, as do the Γ_2 and Γ_4 representations. Members of the same homometric pair cannot be distinguished by unpolarized neutron scattering [19]. Different homometries may still be distinguished through unpolarized diffraction by the presence of the 100 magnetic reflection which is found only for the Γ_1 and Γ_3 representations.

In Figs. 3(a)–3(f) we show detailed neutron diffraction results for YSZ-250 nm and Al₂O₃-200 nm as examples, noting that similar measurements were made on all six films [14]. The 101 reflection, which is entirely of magnetic origin, is present at low temperatures for all films on both YSZ and Al₂O₃ substrates, including films with thicknesses of only 70 and 20 nm as shown in Figs. 3(g) and 3(h), respectively, and clearly absent above the transition temperature determined by magnetometry. Our measurements show no evidence of magnetic scattering above 155 K regardless of thickness, as demonstrated in Fig. 3(i) in which the temperature dependence of the 101 reflection is shown for films fabricated on Al₂O₃ with thicknesses from 20 to 250 nm.

The temperature dependence of several other magnetic reflections measured on warming is shown in Figs. 3(c) and 3(f). The antiferromagnetic ordering temperature T_N is determined by fitting the 101 and 102 reflections

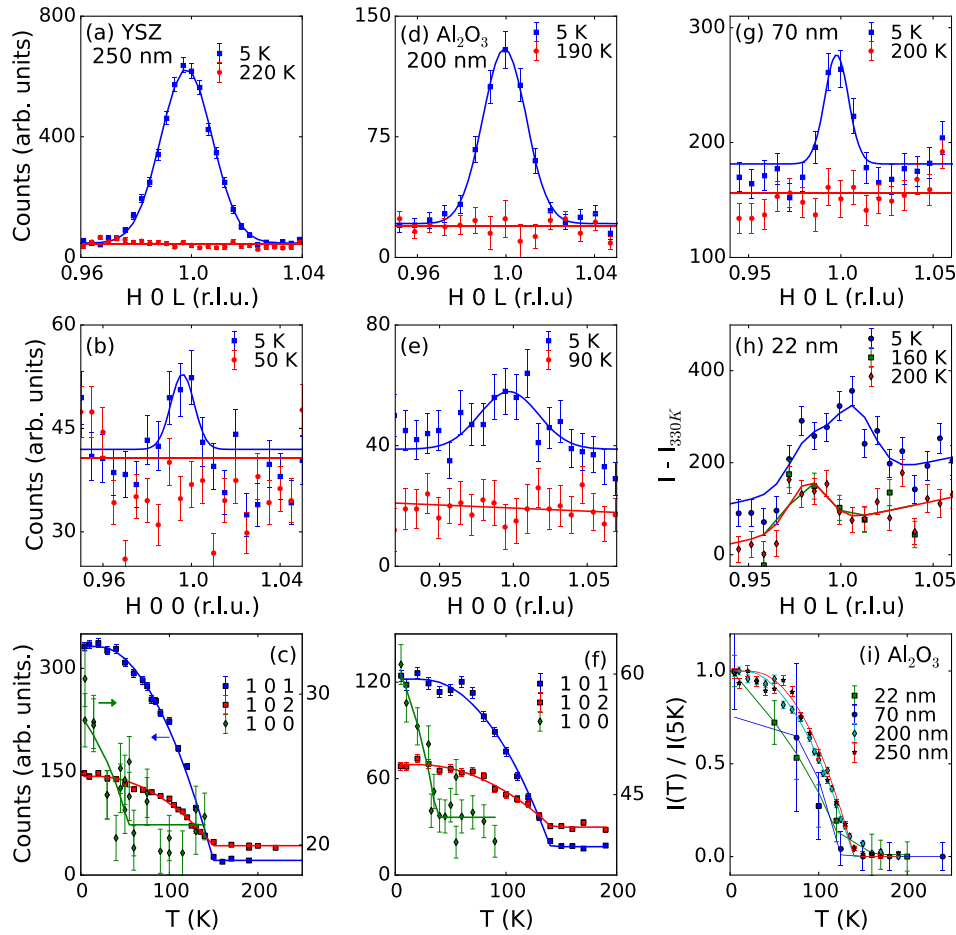


FIG. 3 (color online). Determination of the antiferromagnetic structure using neutron diffraction. The scattered intensity of the magnetic 101 and 100 reflections above and below T_N and temperature dependence for the (a)–(c) YSZ-250 nm and (d)–(f) Al_2O_3 -200 nm. (g)–(h) Intensity of the 101 reflection Al_2O_3 -70 nm and Al_2O_3 -20 nm, respectively. (i) Temperature dependent intensity of the 101 reflection for films deposited on Al_2O_3 . Solid lines in (c), (f), and (i) are fits with mean-field order parameter function, while others are Gaussian.

with a mean-field order parameter, from which we find $115(20) \text{ K} < T_N < 155(5) \text{ K}$ for all samples (Table 1). These ordering temperatures agree well with the onset of ferromagnetism obtained from magnetometry, indicating that both in-plane magnetic order and canted moments develop simultaneously and only well below room temperature in these stoichiometric h - LuFeO_3 films.

These results directly contradict the interpretation of the temperature dependence of the 102 reflection in a stack of 20 nm films detailed in a previous report [6]. The intensity of the 102 reflection is extremely sensitive to the precise symmetry of the structural phase. For example, relative to that expected for the polar $P6_3cm$ phase, the structural contribution to the 102 intensity is larger for the nonpolar, centrosymmetric $P\bar{3}c$ phase (which is consistent with the arrangement of the Lu atoms in the TEM images for their samples [6]) and smaller for the $P6_3mmc$, and $P6_3mcm$ phases. It is plausible that the apparent transition reported in Ref. [6] is not magnetic in nature, but rather represents a structural transition near or above room temperature. As in

that study many films were coaligned, only a small fraction of the structure in any particular film would have to transform to change the 102 peak intensity substantially.

Significant intensity is also observed at the 100 reflection for the films in Ref. 6 though it vanishes near 130 K, which is roughly consistent with T_N for the films in our current study. Several of our films also have temperature-dependent 100 scattering [Figs. 3(b) and 3(e)], though this reflection does not emerge simultaneously with the 101 and 102 magnetic reflections. Rather, the appearance of the 100 reflection is consistent with a reorientation of the moments within the $hk0$ plane below T_N [20]. The reorientation temperature, T_R , is again determined from a fit of a mean-field order parameter of the 100 intensity, from which we find $T_R = 53 \pm 3 \text{ K}$ (YSZ-250 nm) and $38 \pm 3 \text{ K}$ (Al_2O_3 -200 nm), while no such reorientation is discernable for YSZ-200 nm or Al_2O_3 -250 nm [14]. For YSZ-250 nm and Al_2O_3 -200 nm, the ground state magnetic structure can be described by a combination of the $\Gamma_1 + \Gamma_2$ representations as shown in Fig. 4(e), and is

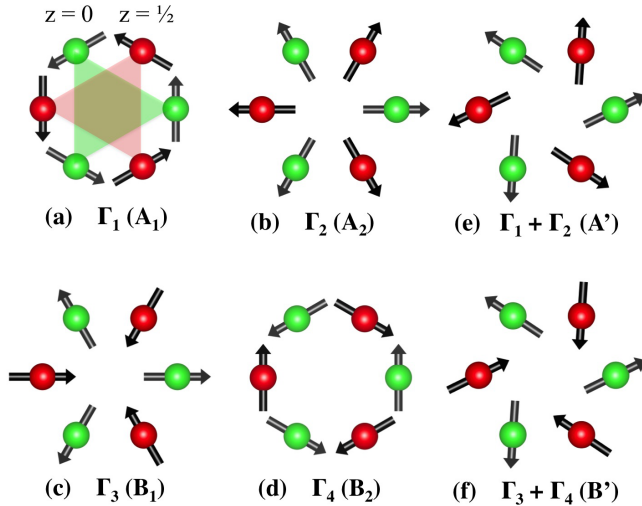


FIG. 4 (color online). (a)–(d) Illustration of the four one-dimensional representations for h -LuFeO₃. The magnetic structures below T_R are shown in (e) and (f) and consist of combinations of the representations in (a)–(d). Labels in parenthesis refer to the equivalent notation used in Ref. [12], for example.

consistent with that suggested previously [6], while a single Γ_2 representation alone is adequate to describe Al₂O₃-250 nm. From the relative intensities of the 100 and 101 reflections we find this effect is quite small, with a maximum possible rotation of only 15° in plane and with no effect on the ferromagnetic moment we observe. Determination of the structural origin of the variation (or absence) of T_R in our samples would require a precise crystallographic refinement of the Fe position and distortion of the O bipryamid [21,22] that is not feasible due to the geometric characteristics of these epitaxial films.

As no spin reorientation was observed in Al₂O₃-250 nm, we may easily refine the magnetic structure including the magnitude of the ordered Fe moments at 5 K from the integrated intensities of several magnetic and structural peaks. The in-plane magnetic structure is refined using the Γ_2 representation, from which we extract an ordered magnetic moment of 2.9(5) μ_B /Fe [14]. The moment is reduced from that expected for the $S = 5/2$ Fe³⁺, but follows similar observations of reduced moments in hexagonal manganites [18,19]. While this refinement was performed using only a single magnetic domain, we note that including equal populations of magnetic domains [12] produces a statistically similar refinement of the data with a comparable magnetic moment on the Fe site.

We conclude that uniform films with variable thickness of metastable h -LuFeO₃ can be stabilized on different substrates. Our films exhibit robust canted antiferromagnetic order below 155 K, which is substantially below the value (440 K) previously reported [6]. Furthermore, we have demonstrated that the magnetic structure in the ordered state of h -LuFeO₃ does not depend on the

underlying substrate or film thickness and that the canting and Néel state appear as a single transition; the differences (in T_N , for example) that do occur among our samples cannot be attributed to differences in strain. The universal appearance of a ferromagnetically canted antiferromagnet in the ferroelectric state indicates that the films contain the proper symmetries to support coupling of the ferromagnetic moment directly to an electric field as theoretically proposed [12]. In future work, it will prove interesting to determine whether this observed canted magnetic moment is indeed switchable with electric field, since the films are ferroelectric at temperatures well above room temperature. If so, then further efforts will be warranted to determine if it is possible to increase the magnetic transition temperature in this system, or whether the lessons we learn from this material can be applied in the hunt for materials with similar magnetic properties, but with higher transition temperatures.

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